

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/807,529	TRAN, HIEU TRUNG
	Examiner	Art Unit
	Emerson C. Puente	2113

**SEARCHED**

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East Search (see attachment)	1/10/2007	EP
Inventor Name Search	1/10/2007	EP
NPL (Google, IEEE, ACM)- key words: debug agent and traps	1/10/2007	EP
717/124,127-129 (text search only)	1/10/2007	EP
714/47 (text search only)	1/10/2007	EP

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner